

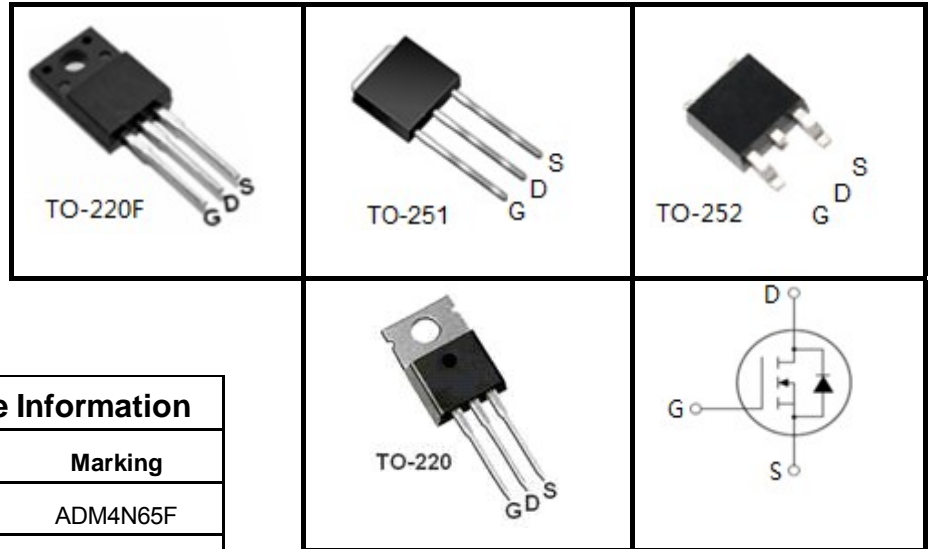
## 650V N-Channel Enhancement Mode Field Effect Transistor

### FEATURES

- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

### APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)



### Device Marking and Package Information

Device	Package	Marking
ADM4N65F	TO-220F	ADM4N65F
ADM4N65	TO-220	ADM4N65
ADM4N65D	TO-251	ADM4N65D
ADM4N65E	TO-252	ADM4N65E

### Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ , unless otherwise noted

Parameter	Symbol	Value				Unit
		TO-220	TO-220F	TO-252	TO-251	
Drain-Source Voltage (V <sub>GS</sub> = 0V)	V <sub>DSS</sub>	650				V
Continuous Drain Current	I <sub>D</sub>	4				A
Pulsed Drain Current (note1)	I <sub>DM</sub>	14				A
Gate-Source Voltage	V <sub>GSS</sub>	± 30				V
Single Pulse Avalanche Energy (note2)	E <sub>AS</sub>	80				mJ
Avalanche Current (note1)	I <sub>AR</sub>	4				A
Repetitive Avalanche Energy (note1)	E <sub>AR</sub>	48				mJ
Power Dissipation (T <sub>C</sub> = 25°C)	P <sub>D</sub>	30	45			W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+150				°C

### Thermal Resistance

Parameter	Symbol	Value				Unit
		TO-220F	TO-251	TO-252	TO-220	
Thermal Resistance, Junction-to-Case	R <sub>thJC</sub>	4.1	2.8			°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>thJA</sub>	62.5	60			

**Specifications**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	650	--	--	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 650V, V_{GS} = 0V, T_J = 25^{\circ}C$	--	--	1	$\mu A$
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 30V$	--	--	$\pm 100$	nA
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = 250\mu A$	3.0	--	4.0	V
Drain-Source On-Resistance (Note3)	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 1.75A$	--	2.35	2.8	$\Omega$
Dynamic						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V,$ $V_{DS} = 25V,$ $f = 1.0MHz$	--	452	--	pF
Output Capacitance	$C_{oss}$		--	46.8	--	
Reverse Transfer Capacitance	$C_{rss}$		--	5	--	
Gate Resistance	$R_g$	$V_{GS} = 0V, V_{DS} = 0V, f = 1.0MHz$	--	3	--	$\Omega$
Total Gate Charge	$Q_g$	$V_{DD} = 520V, I_D = 4A,$ $V_{GS} = 10V$	--	14.5	--	nC
Gate-Source Charge	$Q_{gs}$		--	2	--	
Gate-Drain Charge	$Q_{gd}$		--	7.5	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 325V, I_D = 4A,$ $R_G = 25\Omega$	--	34	--	ns
Turn-on Rise Time	$t_r$		--	5	--	
Turn-off Delay Time	$t_{d(off)}$		--	77	--	
Turn-off Fall Time	$t_f$		--	40	--	
Drain-Source Body Diode Characteristics						
Continuous Body Diode Current	$I_S$	$T_C = 25^{\circ}C$	--	--	4	A
Pulsed Diode Forward Current	$I_{SM}$		--	--	12	
Body Diode Voltage	$V_{SD}$	$T_J = 25^{\circ}C, I_{SD} = 1.75A, V_{GS} = 0V$	--	--	1.4	V
Reverse Recovery Time	$t_{rr}$	$V_{GS} = 0V, I_S = 4A,$ $di_F/dt = 100A/\mu s$	--	285	--	ns
Reverse Recovery Charge	$Q_{rr}$		--	1.75	--	$\mu C$

**Notes**

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $L = 10.0mH, V_{DD} = 50V, R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 1\%$

## Typical Characteristics $T_J = 25^\circ\text{C}$ , unless otherwise noted

Figure 1. Output Characteristics ( $T_J = 25^\circ\text{C}$ )

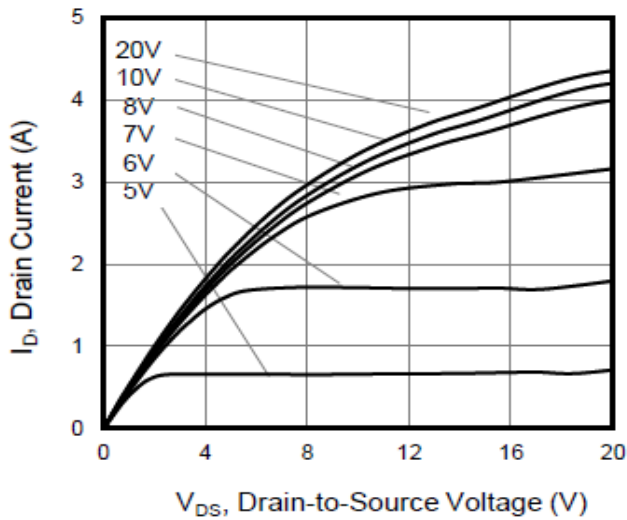


Figure 2. Body Diode Forward Voltage

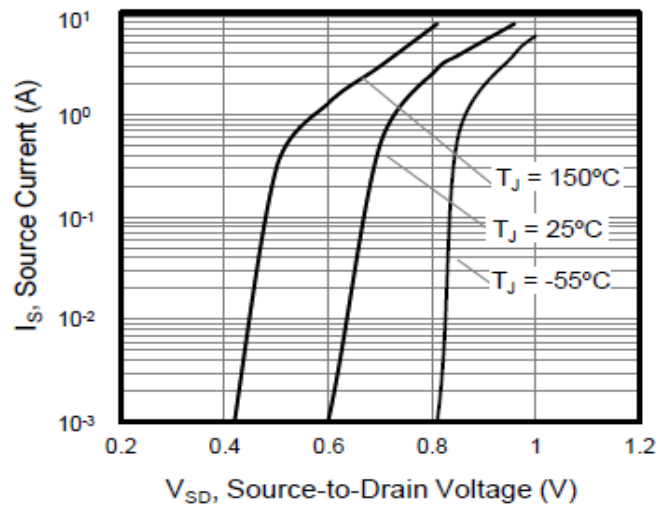


Figure 3. Drain Current vs. Temperature

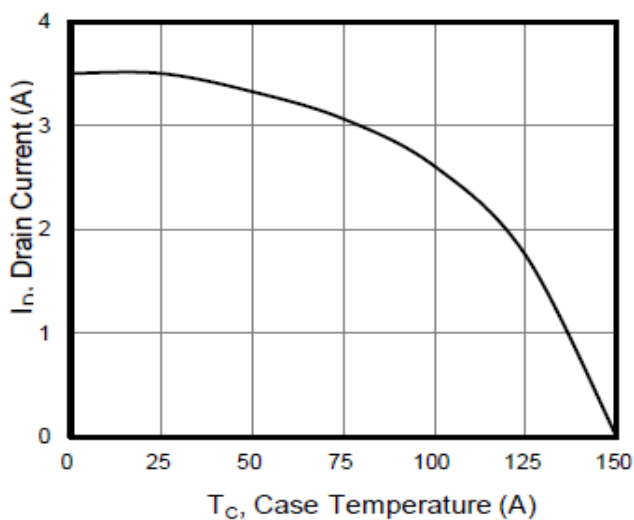


Figure 4.  $BV_{DSS}$  Variation vs. Temperature

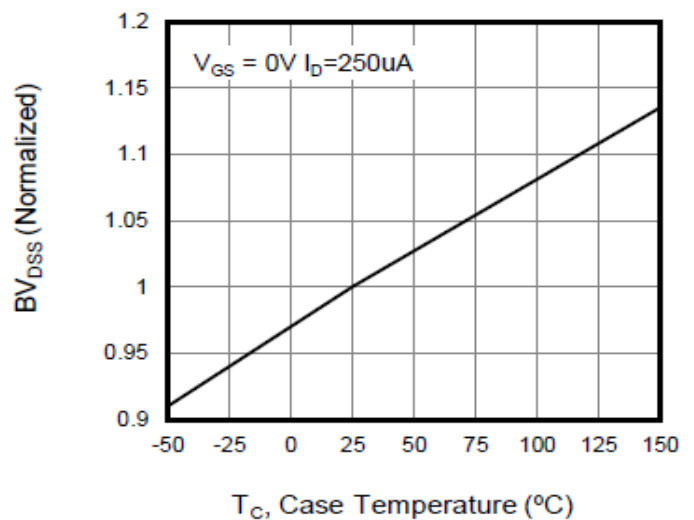


Figure 5. Transfer Characteristics

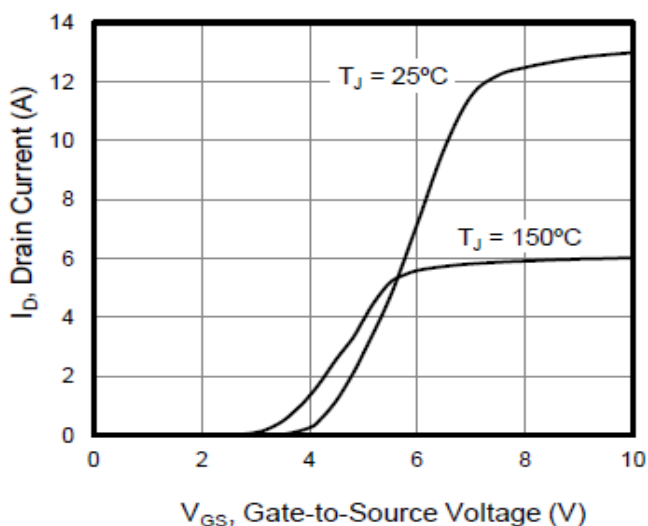


Figure 6. On-Resistance vs. Temperature

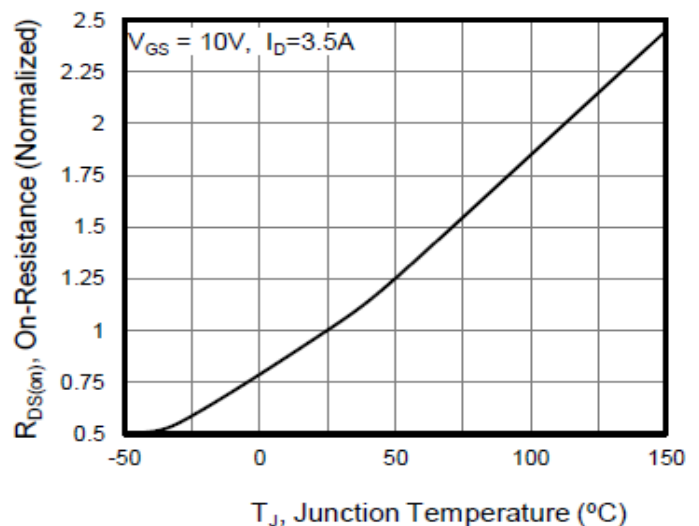


Figure 7. Capacitance

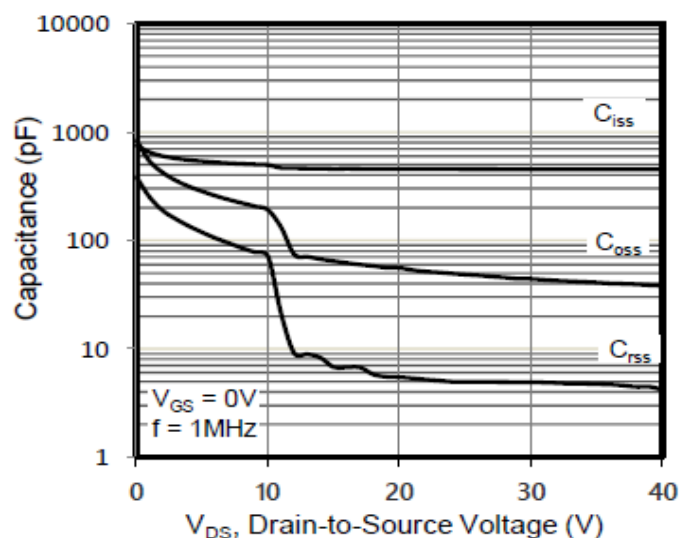


Figure 8. Gate Charge

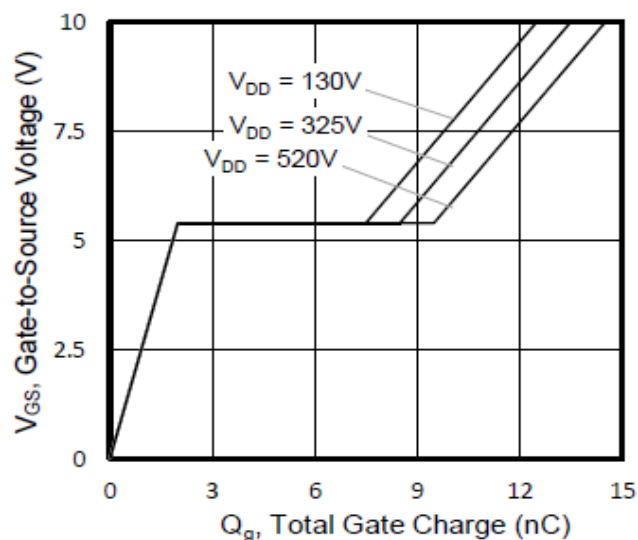


Figure 9. Transient Thermal Impedance  
TO-220F

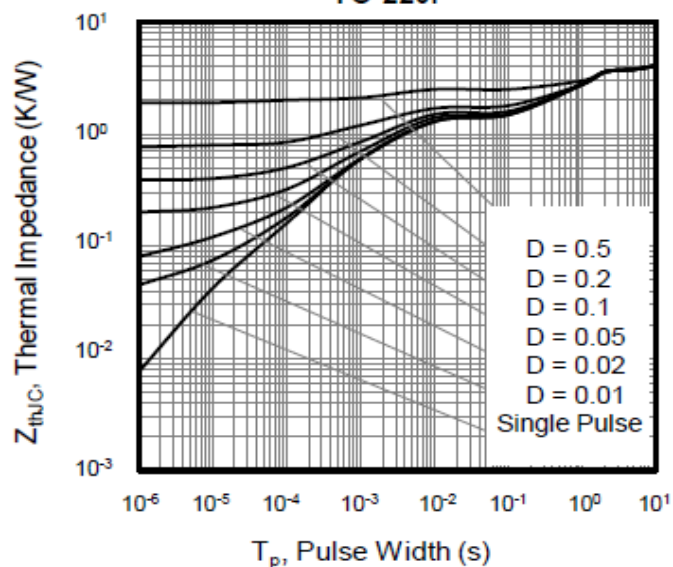


Figure 10. Transient Thermal Impedance  
TO-220, TO-251, TO-252

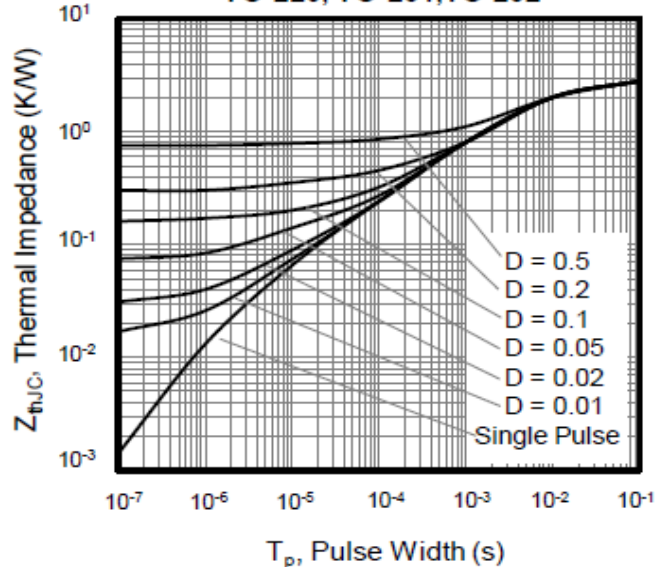


Figure A: Gate Charge Test Circuit and Waveform

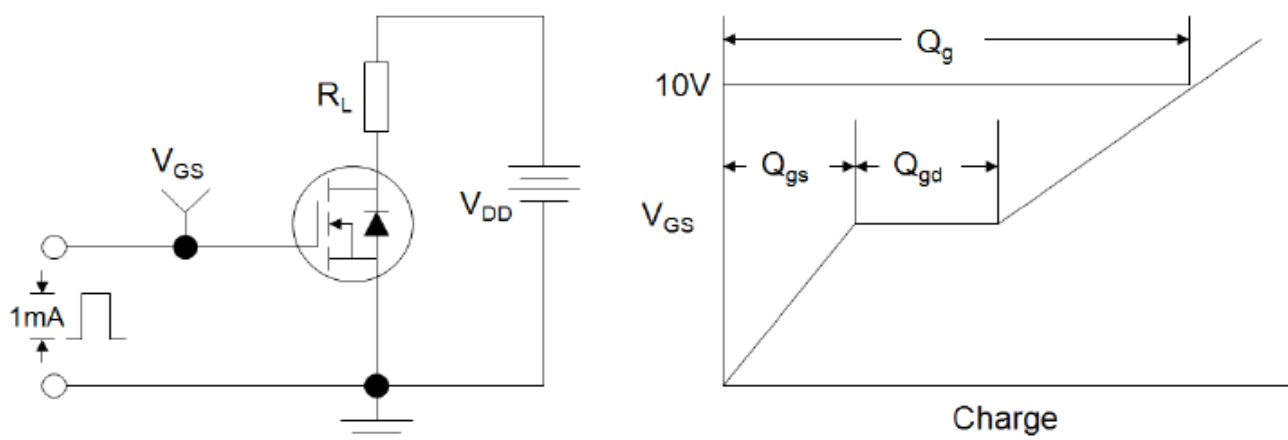


Figure B: Resistive Switching Test Circuit and Waveform

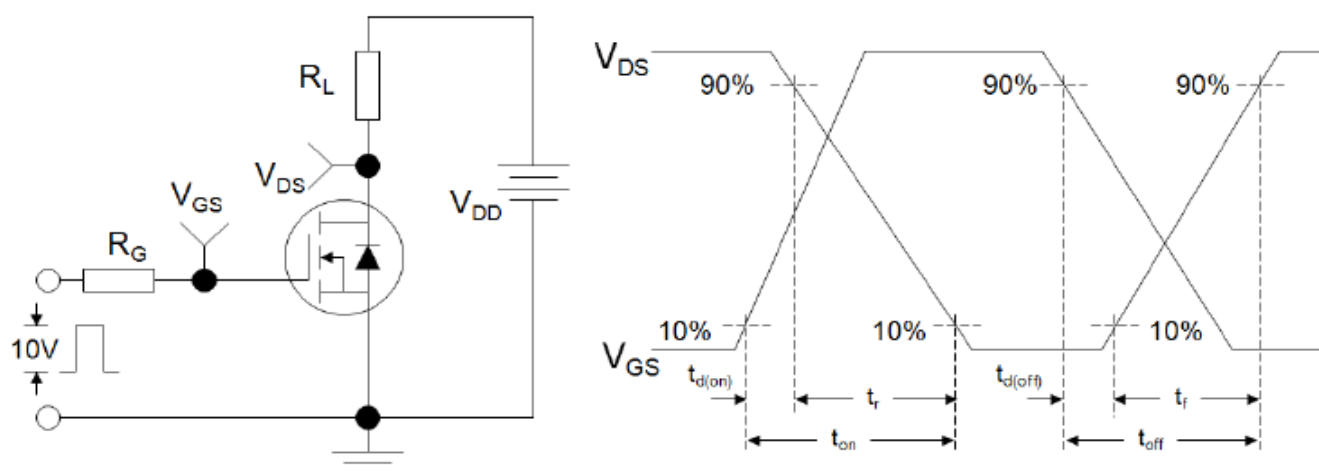
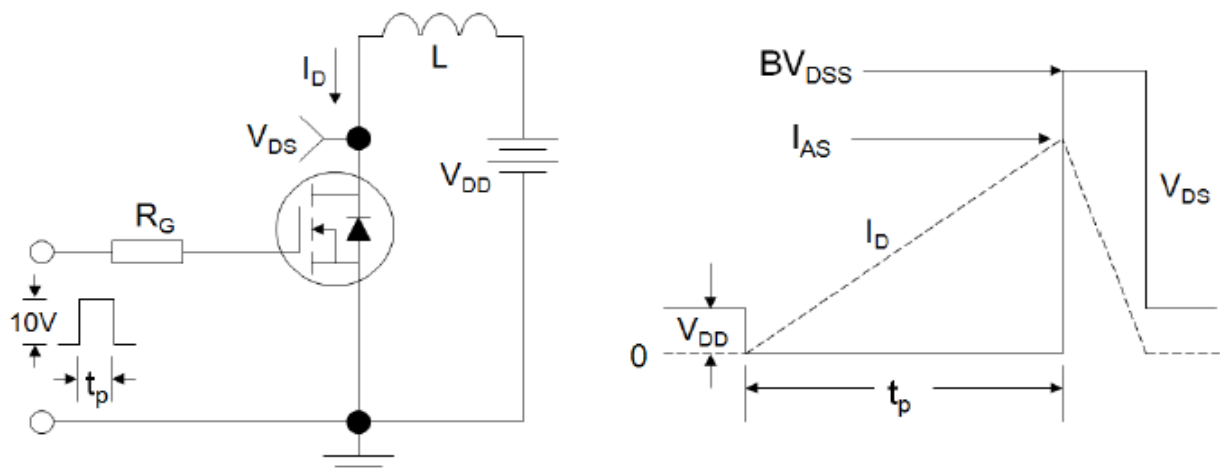
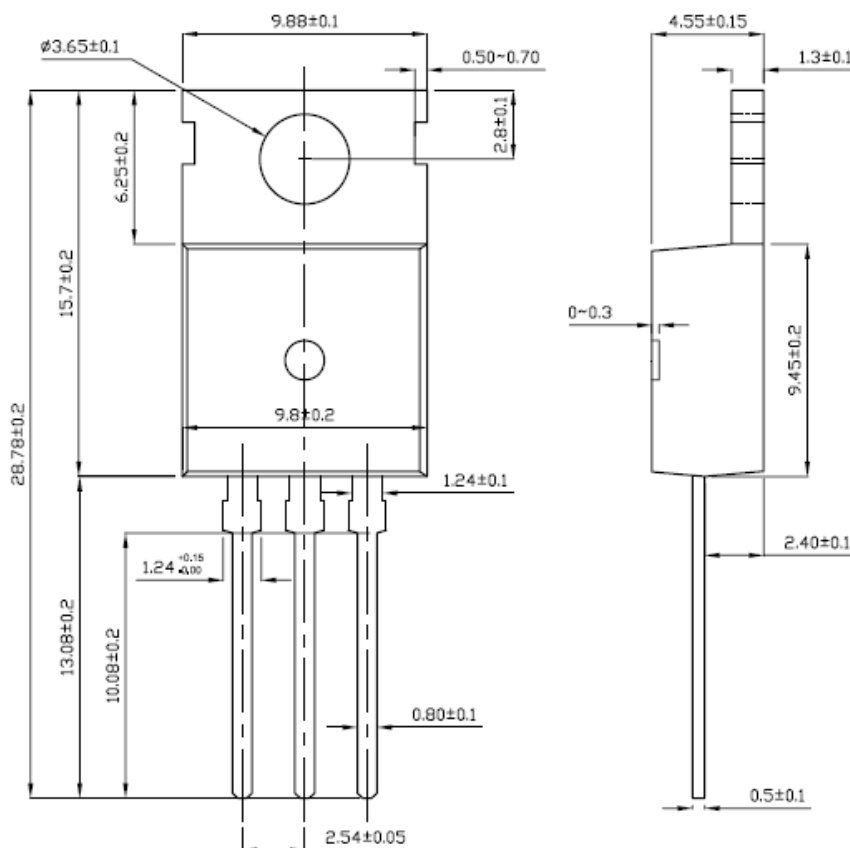


Figure C: Unclamped Inductive Switching Test Circuit and Waveform

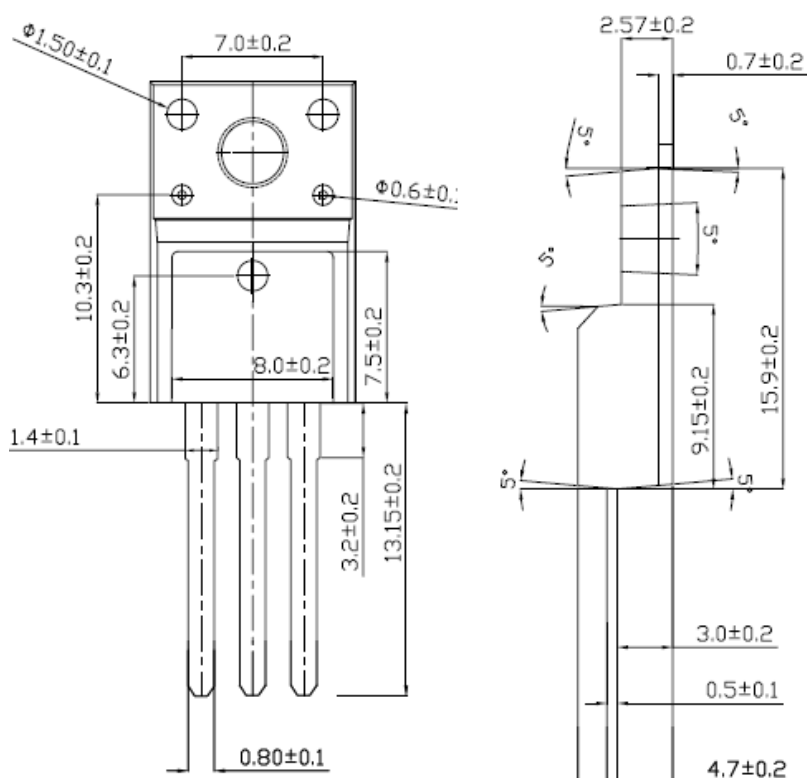


## PACKAGE MECHANICAL DATA

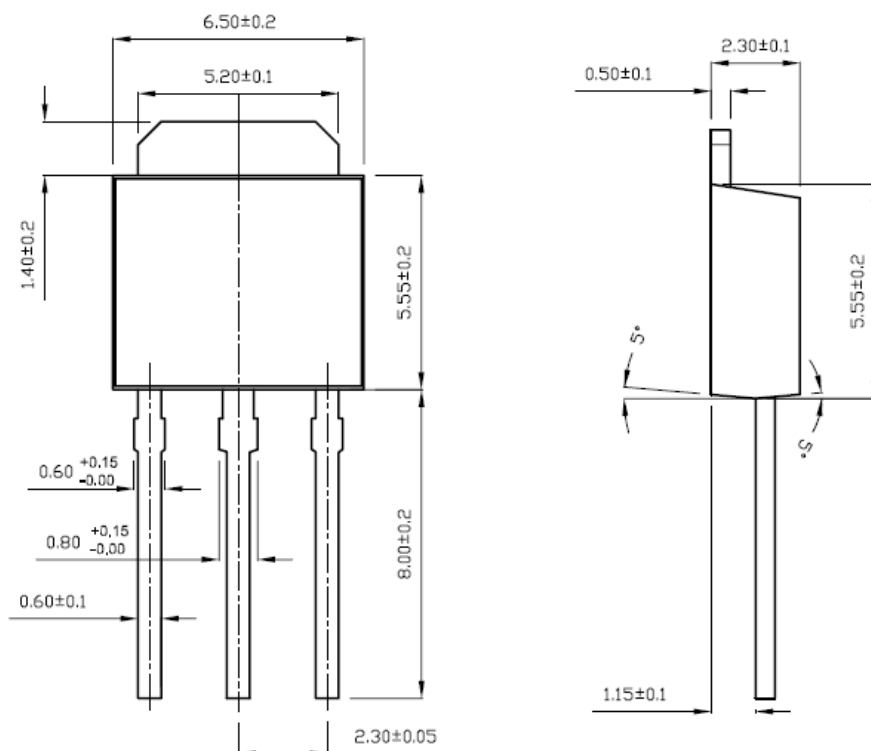
### TO-220 Package Dimension



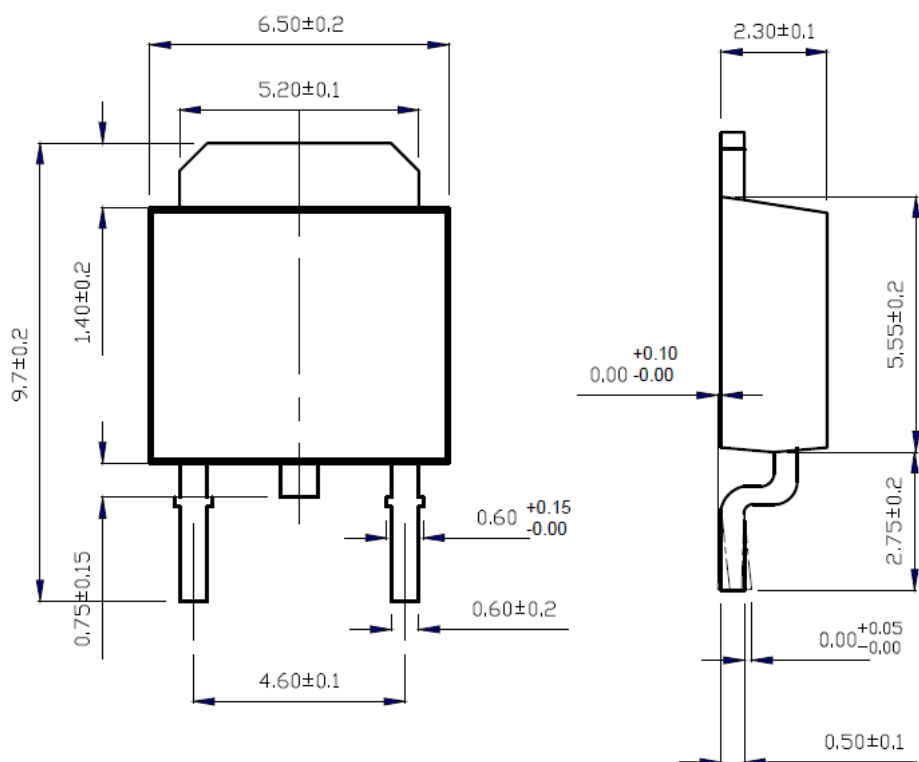
### TO-220F Package Dimension



### TO-251 Package Dimension



### TO-252 Package Dimension



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